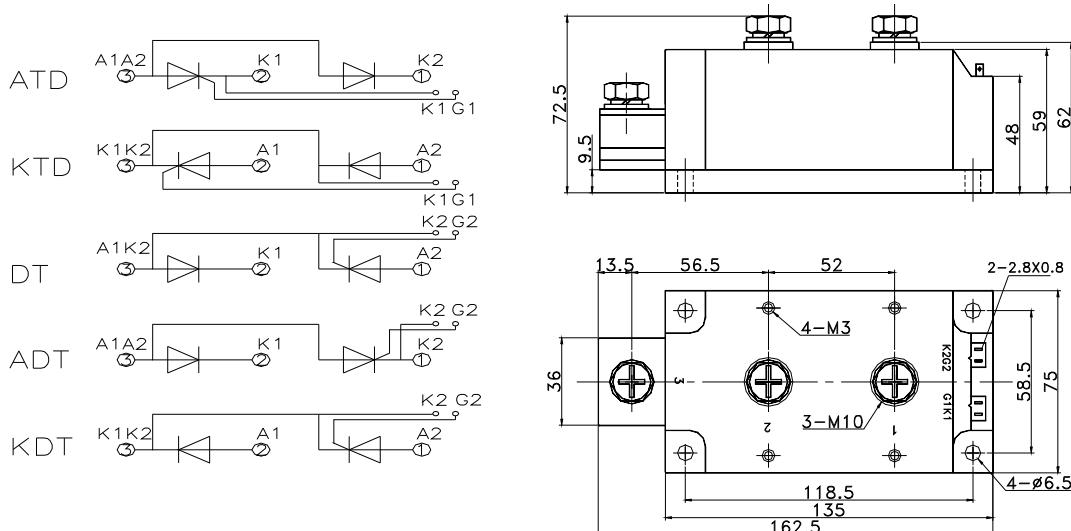


SYMBOL	CHARACTERISTIC	TEST CONDITIONS	$T_j$ (°C)	VALUE			UNIT
				Min	Type	Max	
$I_{T(AV)}$ $I_{F(AV)}$	Mean on-state current	180° half sine wave 50Hz Single side cooled, $T_c=85^\circ C$	125			500	A
$I_{T(RMS)}$	RMS on-state current	Single side cooled, $T_c=85^\circ C$	125			785	A
$V_{DRM}$ $V_{RRM}$	Repetitive peak off-state voltage Repetitive peak reverse voltage	$V_{DRM} \& V_{RRM}$ tp=10ms $V_{DsM} \& V_{RsM} = V_{DRM} \& V_{RRM} + 200V$ respectively	125	600		1800	V
$I_{DRM}$ $I_{RRM}$	Repetitive peak current	at $V_{DRM}$ at $V_{RRM}$	125			40	mA
$I_{TSM}$	Surge on-state current	10ms half sine wave	125			16.0	KA
$I^2t$	$I^2T$ for fusing coordination	$V_R=60\%V_{RRM}$				1310 $A^2s * 10^3$	
$V_{TO}$	Threshold voltage		125			0.80	V
$r_T$	On-state slop resistance					0.34	$m\Omega$
$V_{TM}$	Peak on-state voltage	$I_{TM}=1500A$	125			1.44	V
$dv/dt$	Critical rate of rise of off-state voltage	$V_{DM}=67\%V_{DRM}$	125			800	V/ $\mu$ s
$di/dt$	Critical rate of rise of on-state current	From 67% $V_{DRM}$ to 1500A, Gate source 1.5A $t_r \leq 0.5\mu s$ Repetitive	125			100	A/ $\mu$ s
$I_{GT}$	Gate trigger current		25	30		200	mA
$V_{GT}$	Gate trigger voltage	$V_A=12V, I_A=1A$		1.0		3.0	V
$I_H$	Holding current			20		100	mA
$V_{GD}$	Non-trigger gate voltage	At 67% $V_{DRM}$	125			0.2	V
$R_{th(j-c)}$	Thermal resistance Junction to heatsink	At 180° sine Single side cooled				0.065	$^\circ C / W$
$V_{iso}$	Isolation voltage	50Hz, R.M.S, t=1min, $I_{iso}:1mA$ (MAX)		2500			V
$F_m$	Thermal connection torque(M10)				0.60		N·m
	Mounting torque(M6)				0.30		N·m
$T_{stg}$	Stored temperature			-40		140	$^\circ C$
$W_t$	Weight				2300		g
Outline		408F3					

## OUTLINE DRAWING & CIRCUIT DIAGRAM



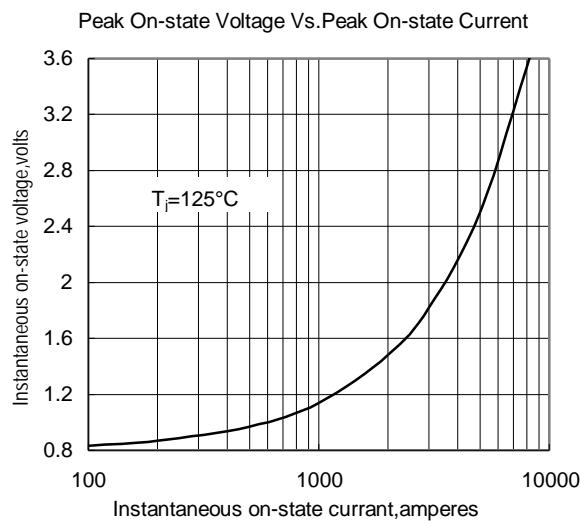


Fig.1

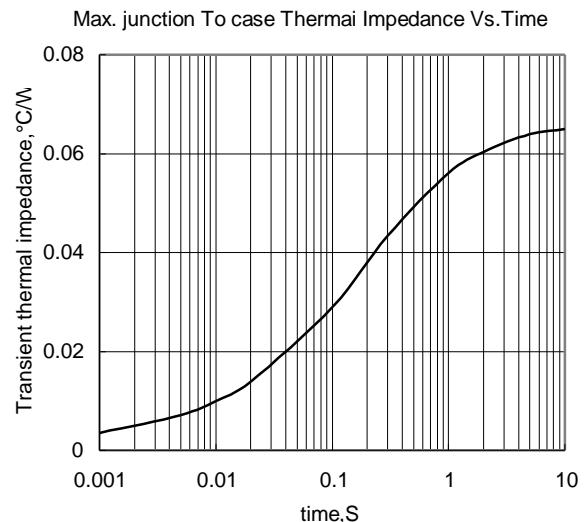


Fig.2

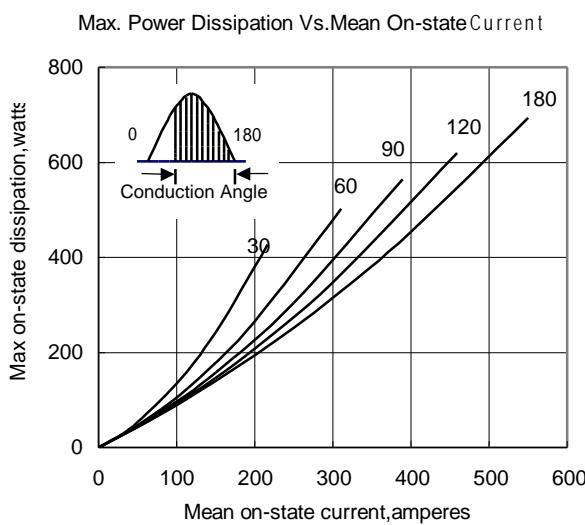


Fig.3

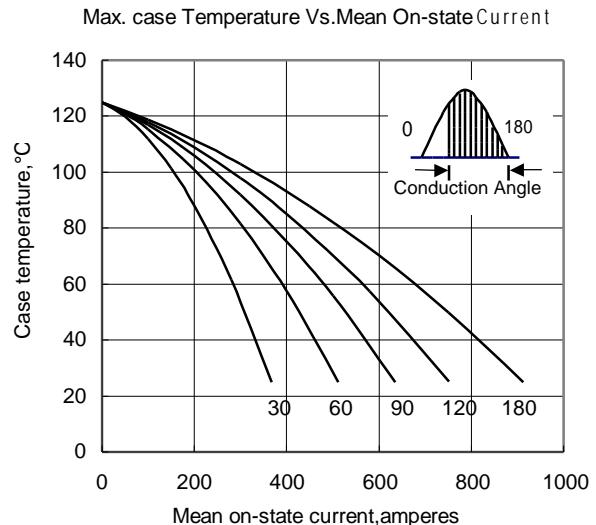


Fig.4

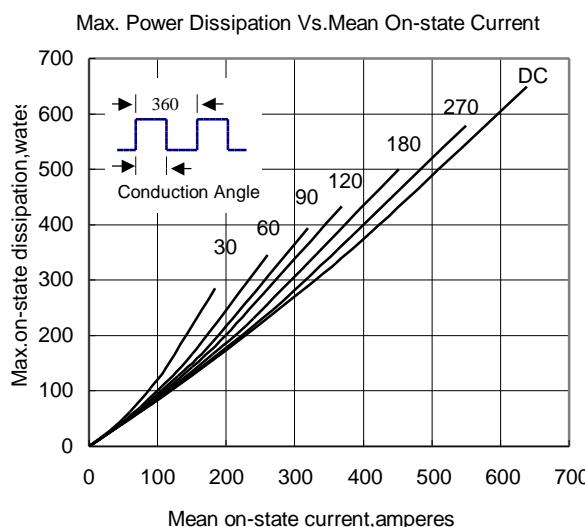


Fig.5

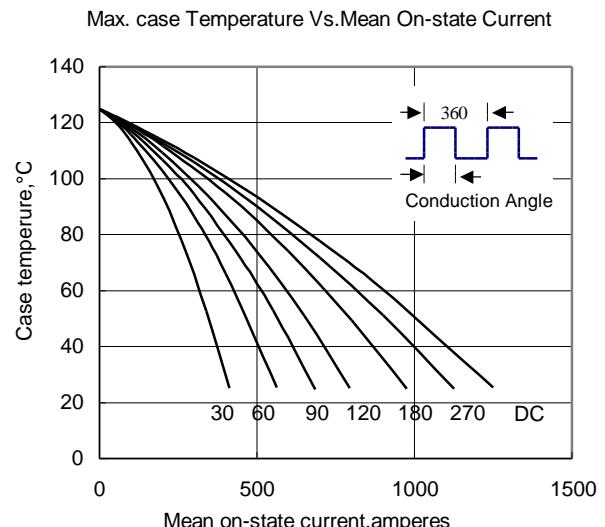


Fig.6

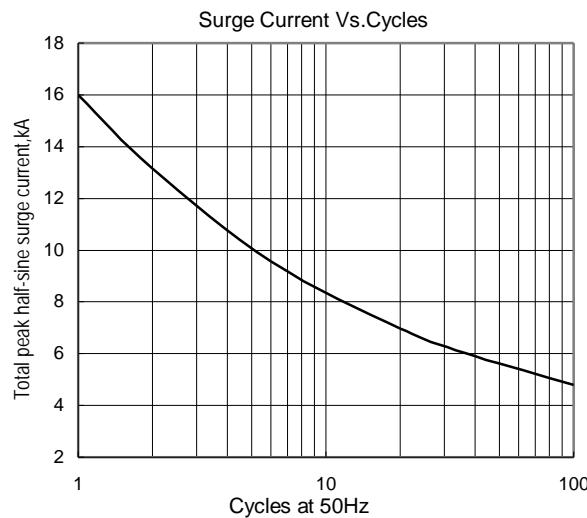


Fig.7

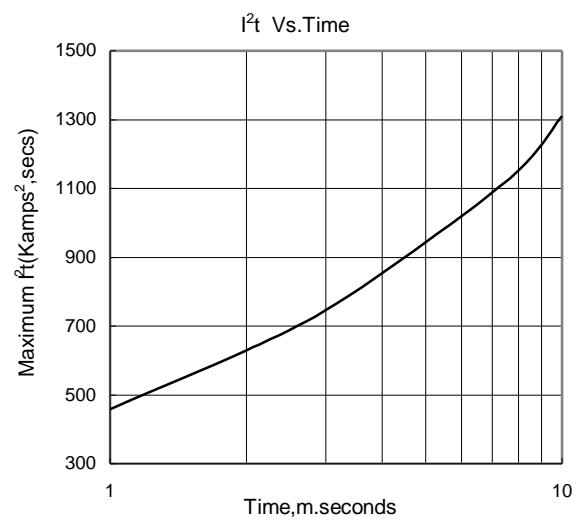


Fig.8

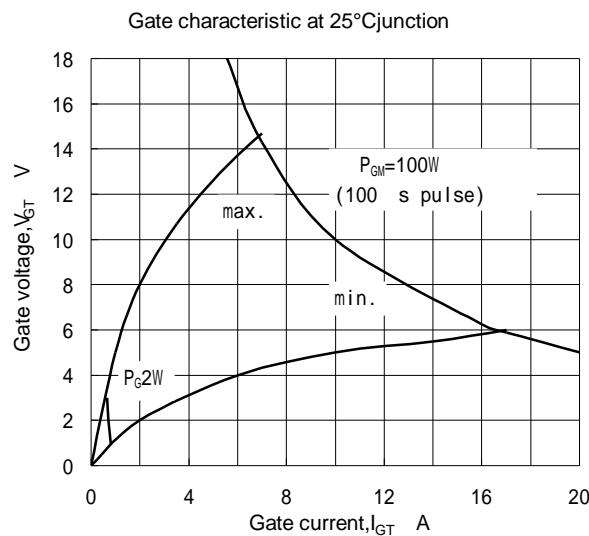


Fig.9

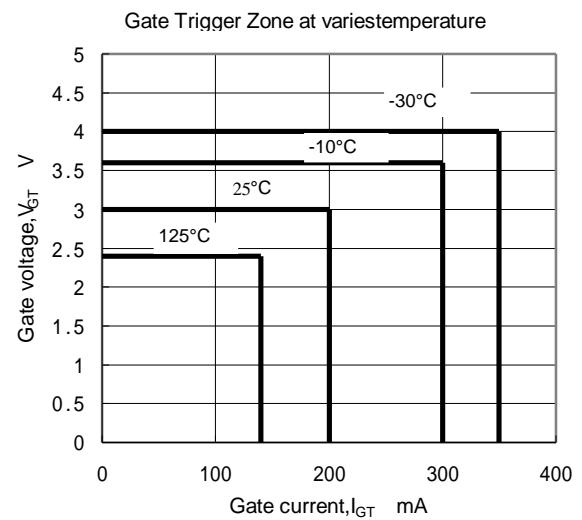


Fig.10